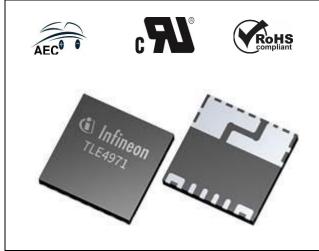
TLE4971 high precision coreless current sensor for automotive applications in 8x8mm SMD package



#### **Features & Benefits**

- Integrated current rail with typical 220μΩ insertion resistance enables ultra-low power loss
- Less than 1nH parasitic inductance
- Smallest form factor, 8x8mm SMD, for easy integration and board area saving
- High accurate, scalable, DC & AC current sensing
- 210kHz bandwidth enables wide range of applications
- Very low sensitivity error over temperature
- Galvanic functional isolation up to 1150V peak VIORM



Coreless current sensor in PG-TISON-8 package

#### Description

TLE4971 is a high precision miniature coreless magnetic current sensor for AC and DC measurements with analog interface and two fast over-current detection outputs.

Infineon's well-established and robust monolithic Hall technology enables accurate and highly linear measurement of currents with a full scale up to  $\pm 120A$ . The sensor is equipped with internal selfdiagnostic feature.

Typical applications are Onboard Chargers as well as any kind of Drives.

The differential measurement principle allows great stray field suppression for operation in harsh environments.

Two separate interface pins (OCD) provide a fast output signal in case a current exceeds a pre-set threshold.

The sensor is shipped as a fully calibrated product without requiring any customer end-of-line calibration.

All user-programmable parameters such as OCD thresholds, blanking times and output configuration modes are stored in an embedded EEPROM memory.

Product Name	Product Type	Marking	Ordering Code	Package
TLE4971-A120N5-E0001	120A range	H71E1A1_N	SP005737183	PG-TISON-8-5
TLE4971-A075N5-E0001	75A range	H71E3A1_N	SP005737179	PG-TISON-8-5
TLE4971-A050N5-E0001	50A range	H71E4A1_N	SP005737136	PG-TISON-8-5
TLE4971-A025N5-E0001	25A range	H71E6A1_N	SP005737132	PG-TISON-8-5
TLE4971-A120N5-U-E0001	120A range, UL-certified	H71E1A1UN	SP005737204	PG-TISON-8-5
TLE4971-A075N5-U-E0001	75A range, UL-certified	H71E3A1UN	SP005737200	PG-TISON-8-5
TLE4971-A050N5-U-E0001	50A range, UL-certified	H71E4A1UN	SP005737196	PG-TISON-8-5
TLE4971-A025N5-U-E0001	25A range, UL-certified	H71E6A1UN	SP005737188	PG-TISON-8-5

#### **Order Information**



## **Pin Configuration**

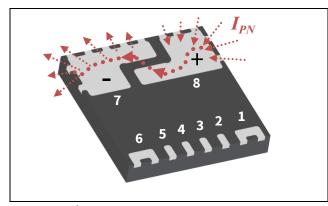


Figure 1 Pin layout PG-TISON-8 The current  $I_{PN}$  is measured as a positive value when it flows from pin 8 (+) to pin 7 (-) through the integrated current rail.

Pin configu	ration	
Pin No.	Symbol	Function
1	VDD	Supply voltage
2	GND	Ground
3	VREF	Reference voltage input or
		output
4	AOUT	Analog signal output
5	OCD1	Over-current detection output 1 (open drain output)
6	OCD2	Over-current detection output 2 (open drain output)
7	IP-	Negative current terminal pin (current-out)
8	IP+	Positive current terminal pin (current-in)

## **Target Applications**

The TLE4971 is suitable for AC as well as DC current measurement applications:

- On-Board Charger (OBC)
- Drives / Servo / Motor Control / Inverter / eScooter / eBike / LEV
- Current monitoring
- Overload and over-current detection

Due to its implemented magnetic interference suppression, it is extremely robust when exposed to external magnetic fields. The device is suitable for fast over-current detection with a configurable threshold level. This allows the control unit to switch off and protect the affected system from damage, independently from the main measurement path.

#### **Standard Product Configuration**

Table I Stanuaru Product	Configuration			
Parameter	TLE4971-A120xxx	TLE4971-A075xxx	TLE4971-A050xxx	TLE4971-A025xxx
Full scale range 1)	±120A	±75A	±50A	±25A
Output mode	Semi-differential	Semi-differential	Semi-differential	Semi-differential
Quiescent voltage	1.65V	1.65V	1.65V	1.65V
OCD1 threshold factor <sup>2)</sup>	1.25	1.25	1.25	1.25
OCD1 threshold factor <sup>2)</sup>	0.82	0.82	0.82	0.82
OCD filter time both channels <sup>2)</sup>	Oμs	Oμs	Oμs	Oµs
Ratiometric mode	No	No	No	No

Table 1 Standard Product Configuration

1) Optional sensitivity values are mentioned in Table 5.

2) Optional OCDx configuration are listed in Table 7 and Table 8.



## **Block Diagram**

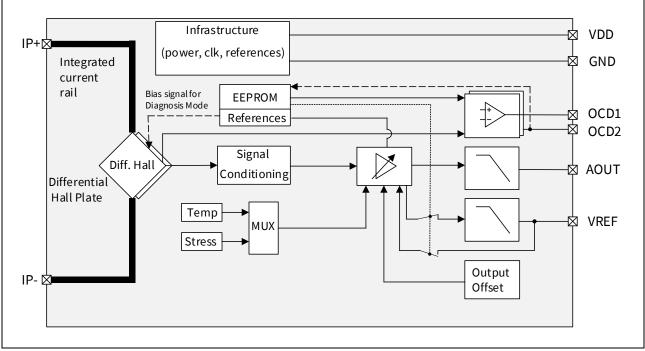


Figure 2 Block Diagram

#### **General Description**

TLE4971 is a high speed precision current sensor. Due to implemented EEPROM various configuration can be applied without using any external components.

Depending on the selected programming option, the analog output signal can be provided either as:

- Single-ended
- Fully-differential
- Semi-differential

In **single-ended** mode, the pin VREF is used as a reference voltage input. The analog output signal is provided on pin AOUT.

In **fully-differential** mode, both AOUT (positive polarity) and VREF (negative polarity) are used as signal outputs whereas VDD is used as reference voltage input.

In semi-differential mode a chip-internal reference voltage is used and provided on VREF (output).

For fast over-current detection, the raw analog signal provided by the Hall probes is fed into comparators with programmable switching thresholds.

A user-programmable deglitch filter is implemented to enable the suppression of fast switching transients. The open-drain outputs of the OCD pins are active "low" and they can be directly combined into a wired-AND configuration on board level to have a general over-current detection signal.

Programming of the memory can be performed in circuit through a Serial Inspection and Configuration Interface (SICI). The interface is descripted in detail in the programming guide which can be found on the Infineon webside.



#### **Absolute Maximum Ratings**

Table 2 Absolute Maximum Ratings

General conditions (unless otherwise specified):  $V_{DD}$  = 3.3V;  $T_S$  = -40°C ... +125°C

Parameter	Symbol	Min	Тур	Max	Unit	Note / Test Condition
Current constants	14	-0.3	3.3	3.6	V	
Supply voltage	V <sub>DD</sub>	-	-	6.5	V	duration < 1 minute
Primary nominal rated current LF <sup>1)</sup>	I <sub>PNRLF</sub>	-70	-	70	А	Peak, frequency < 10Hz. Tested on Infinenon reference PCB (see related application note: AppNote TLx4971 PCB)
Primary nominal rated current HF <sup>2)</sup>	Ipnrhf	-70	-	70	А	RMS, frequency ≥ 10Hz. Tested on Infinenon reference PCB (see related application note: AppNote TLx4971 PCB)
Primary current	I <sub>PNS</sub>	-250	-	250	A	Single peak for 10µs, 10 assertions per lifetime
Voltage on interface pins VREF, OCD1, AOUT	V <sub>IO</sub>	-0.3	-	V <sub>DD</sub> + 0.3	v	
Voltage on Interface pin OCD2	V <sub>IO_OCD2</sub>	-0.3	-	21	V	
ESD voltage <sup>3)</sup>	V <sub>ESD_HBM</sub>	-2	-	2	kV	
ESD voltage <sup>4)</sup>	V <sub>ESD_SYS</sub>	-16	-	16	kV	In the application circuit
Voltage slew-rate on current rail	<i>∆V</i> /dt	-	-	10	V/ns	
Maximum junction temperature	T <sub>j_max</sub>	-	-	130	°C	
Storage temperature	T <sub>A_STORE</sub>	-40	-	150	°C	
Life time	LT	15	-	-	Years	Considering continuous operation with T <sub>s</sub> = 70°C and I = 30 A RMS

1) Tested with primary nominal rated current of 70A peak on Infineon reference PCB at Low Frequency (LF). Thermal equilibrium reached after 2 min.

2) Tested with primary nominal rated current of 70A rms on Infineon reference PCB at High Frequency (HF). Thermal equilibrium reached after 2 min.

3) Human Body Model (HBM), according to standard AEC-Q 100-002

4) According to standard IEC 61000–4–2 electrostatic discharge immunity test

Stress above the limit values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings. Exceeding only one of these values may cause irreversible damage to the integrated circuit.



# **Product Characteristics**

Table 3 Operating Ranges

General conditions (unless otherwise specified):  $V_{DD}$  = 3.3V;  $T_S$  = -40°C ... +125°C

Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition		
Supply voltage	V <sub>DD</sub>	3.1	3.3	3.5	V			
Ambient temperature at soldering point	Ts	-40	-	125	°C	Measured at soldering point, limited life time of 8800h		
Ambient temperature at soldering point	Ts	-40	-	105	°C	Measured at soldering point, Considering 8 years operation at I = 32 A RMS		
Capacitance on analog output pin	C <sub>AOUT</sub>	4.7	6.8	8	nF	W/o decoupling resistor, including parasitic cap on the board		
Capacitor on VDD	$C_{\rm VDD}$	-	220	-	nF			
Reference input voltage	$V_{REF}$	-	1.65	-	V	Other values available by EEPROM: 1.2V, 1.5V, 1.8V		
Reference input voltage variation	$V_{REF\_var}$	-10	-	10	%			

#### Table 4 Operating Parameters

General conditions (unless otherwise specified):  $V_{DD}$  = 3.3V; T<sub>s</sub> = -40°C ... +125°C

Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Current consumption	I <sub>DD</sub>	-	18	25	mA	I(AOUT) = 0mA
Primary path resistance	R <sub>PN</sub>	-	220	-	μΩ	25°C, when soldered on PCB with 140μm copper thickness
Power-on delay time	t <sub>POR</sub>	-	1.0	1.5	ms	From V <sub>DD</sub> rising above V <sub>DD</sub> (min) to full operation. Output with lower accuracy is available within 0.5 ms. 0A primary input current.
Voltage on interface pin OCD1	V <sub>IO_OCD1</sub>	-0.3	-	3.5	V	
Voltage on interface pin OCD2	V <sub>IO_OCD2</sub>	-0.3	-	3.5	v	In functional mode
Voltage on analog output AOUT	V <sub>AOUT</sub>	-0.3	-	V <sub>DD</sub> + 0.3	V	
Thermal resistance <sup>1)</sup>	<b>R</b> <sub>THJS</sub>	-	0.25	-	K/W	Current rail to soldering point, on Infineon reference PCB (see related application note AppNote TLx4971 PCB)

1) Not subject to production test. Verified by design and characterization.



# **Functional Output Description**

The analog output signal depends on the selected output mode:

- Single-ended
- Fully-differential
- Semi-differential

#### **Single-Ended Output Mode**

In single-ended mode VREF is used as an input pin to provide the analog reference voltage,  $V_{REF}$ . The voltage on AOUT,  $V_{AOUT}$ , is proportional to the measured current  $I_{PN}$  at the current rail:

$$V_{AOUT}(I_{PN}) = V_{OQ} + S \cdot I_{PN}$$

The quiescent voltage  $V_{OQ}$  is the value of  $V_{AOUT}$  when  $I_{PN}$ =0.  $V_{OQ}$  tracks the voltage on VREF

$$V_{OQ}(V_{REF}) = V_{REF}$$

The reference voltage can be set to different values which allow either bidirectional or uniderictional current sensing. The possible values of  $V_{\text{REFNOM}}$  are indicated in Table 3.

The sensitivity is by default non ratiometric to  $V_{\text{REF.}}$ If ratiometricity is activated the sensitivity becomes as follows:

$$S(V_{REF}) = S(V_{REFNOM}) \cdot \frac{V_{REF}}{V_{REFNOM}}$$

#### **Fully-Differential Output Mode**

In fully-differential output mode, both VREF and AOUT are analog outputs to achieve double voltage swing: AOUT is the non-inverting output, while VREF is the inverting output:

$$V_{AOUT}(I_{PN}) = V_{QAOUT} + S \cdot I_{PN}$$
$$V_{REF}(I_{PN}) = V_{QREF} - S \cdot I_{PN}$$

The quiescent voltage is derived from the supply pins VDD and GND and has the same value on both AOUT and VREF:

$$V_{QAOUT}(V_{DD}) = V_{QREF}(V_{DD}) = \frac{V_{DD}}{2}$$

The sensitivity in the fully-differential mode can be generally expressed as:

$$S(V_{DD})_{diff} = S(3.3V)_{diff} \cdot \frac{V_{DD}}{3.3V}$$

In this mode, the quiescent voltages and the sensitivity are both ratiometric with respect to  $V_{\text{DD}}$  if ratiometricity is enabled.

## Semi-Differential Output Mode

In semi-differential output mode, the sensor is using a chip-internal reference voltage to generate the quiescent voltage that is available on pin VREF (used as output).

The analog measurement result is available as single-ended output signal on AOUT. The dependence of sensitivity and output offset on reference voltage is the same as described in single- ended output mode.

The quiescent voltage is programmable at 3 different values,  $V_{OQbid_1}$  and  $V_{OQbid_2}$  for bidirectional current and  $V_{OQuni}$  for unidirectional current (see Table 5).



#### **TLE4971** Datasheet

**Table 5 Analog Output Characteristics** 

General conditions (unless otherwise specified):  $V_{DD} = 3.3V$ : T<sub>s</sub> = -40°C. . +125°C

Parameter	Symbol	Min	Тур	Max	Unit	Note / Test conditions
Quiescent output voltage (bidirectional option 1) <sup>1)2)</sup>	$V_{OQbid_1}$	-	V <sub>DD</sub> /2	-	V	I <sub>PN</sub> = 0A; fully- differential or semi- differential (bidirectional) modes, standard setting
Quiescent output voltage (bidirectional option 2) <sup>2)</sup>	V <sub>OQbid_2</sub>	-	1.5	-	V	IPN = 0A; semi- differential (bidirectional) mode; for this option the ratiometricity offset is disabled
Quiescent output voltage (unidirectional mode) <sup>2)</sup>	$V_{ m OQuni}$	-	V <sub>DD</sub> /5.5	-	V	I <sub>PN</sub> = OA; semi- differential (unidirectional) mode
Sensitivity, range1 <sup>1)2)3)</sup>	<i>S</i> 1	-	10	-	mV/A	±120A FS (Full Scale)
Sensitivity, range2 <sup>2)3)</sup>	<i>S</i> 2	-	12	-	mV/A	±100A FS
Sensitivity, range3 <sup>2)3)</sup>	<i>S</i> 3	-	16	-	mV/A	±75A FS
Sensitivity, range4 <sup>2)3)</sup>	<b>S</b> 4	-	24	-	mV/A	±50A FS
Sensitivity, range5 <sup>2)3)</sup>	<i>S</i> 5	-	32	-	mV/A	±37.5A FS
Sensitivity, range6 <sup>2)3)</sup>	<i>S</i> 6	-	48	-	mV/A	±25A FS
Sensitivity ratiometry factor	Ks	-	1	-	-	
Quiescent ratiometry factor	Koq	-	1	-	-	
Analog output drive capability	I <sub>O</sub>	-2	-	2	mA	DC current
Analog output saturation voltage	V <sub>SAT</sub>	-	150	300	mV	V <sub>DD</sub> -V <sub>AOUT</sub> ; Output current = 2mA
Transfer function cutoff frequency	BW	120	210	-	kHz	-3dB criterion, $C_0 = 6.8$ nF
Output phase delay <sup>4)</sup>	$oldsymbol{arphi}_{delay}$	-	45	60	0	f <sub>signal</sub> = 120kHz
Output noise density <sup>5)6)</sup>	<b>I</b> <sub>NOISE</sub>	-	260	660	µA/√Hz	Typical value is at 25°C.
External homogenous magnetic field suppression <sup>4)</sup>	<b>B</b> <sub>SR</sub>	34	50	-	dB	Frequency up to 150kHz. Up to 20mT homogeneous field applied

1) Pre-configured setting, for other pre-configured versions please contact your local sales.

2) Can be programmed by user (valid only for 120A version).

3) Values refer to semi-differential mode or single-ended mode, with VREF =1.65 V.

In fully-differential mode the sensitivity value is doubled. 4) Not subject to production test. Verified by design and characterization.

5) Typical value in fully-differential mode, sensitivity range S6 6) Noise Density =  $\frac{Output Noise [V_{RMS}]}{\sqrt{\frac{\pi}{2} * BW[Hz]}} * \frac{1}{Sensitivity[\frac{V}{A}]}$ 



Parameter	Symbol	Min	Тур	Max	Unit	Note / Test conditions
Sensitivity error (all ranges)	Esens	-1.5	-	1.5	%	T <sub>s</sub> = 25°C, 0h, ±3σ
Sensitivity error (all	<b>E</b> senst	-2.0	-	2.0	%	$T_{s} = -40^{\circ}C \text{ to } 25^{\circ}C, 0h, \pm 3\sigma$
ranges) over temperature	LSENSI	-1.5	-	1.5	%	T <sub>s</sub> = 25°C to 125°C, 0h, ±3σ
Sensitivity error (all ranges) over temperature and lifetime <sup>4)</sup>	E <sub>SENSL</sub>	-3	-	3	%	
Output offset (all ranges)	EOFF	-180	-	180	mA	T <sub>s</sub> = 25°C, 0h, ±3σ
Output offset (all ranges)	<b>E</b> OFFT	-230	-	230	mA	$T_{s} = -40^{\circ}C \text{ to } 25^{\circ}C, 0h, \pm 3\sigma$
over temperature	LOFFI	-230	-	230	mA	T <sub>s</sub> = 25°C to 125°C, 0h, ±3σ
Output offset (all ranges) over temperature and lifetime <sup>4)</sup>	E <sub>OFF_L</sub>	-500	-	500	mA	
Total error (S1)	E <sub>TOT_S1</sub>	-1.7	-	1.7	%	$T_s = 25^{\circ}C$ , 0h, $\pm 3\sigma$ , includes linearity error
Total error (S1) over		-2.3	-	2.3	%	$T_s = -40$ °C to 25°C, 0h, ±3 $\sigma$ , includes linearity error
temperature	E <sub>tot_s1</sub>	-1.7	-	1.7	%	$T_s = 25^{\circ}C$ to $125^{\circ}C$ , 0h, $\pm 3\sigma$ , includes linearity error
Total error (S6)	E <sub>TOT_S6</sub>	-1.5	-	1.5	%	T <sub>s</sub> = 25°C, 0h, ±3σ, includes linearity error
Total error (S6) over		-2.3	-	2.3	%	$T_s = -40^{\circ}C$ to 25°C, 0h, ±3 $\sigma$ , includes linearity error
cemperature E <sub>T</sub>	E <sub>TOT_S6</sub>	-1.8	-	1.8	%	$T_s = 25^{\circ}C$ to $125^{\circ}C$ , 0h, ± $3\sigma$ , includes linearity error
Total error over temperature and lifetime <sup>4)</sup>	E <sub>TOTL</sub>	-3.45	-	3.45	%	Percentage of FS, sensitivity S1; includes sensitivity, offset and linearity error

Table 5 Analog Output Characteristics (cont'd)

General conditions (unless otherwise specified):  $V_{DD} = 3.3V$ ;  $T_s = -40^{\circ}C \dots +125^{\circ}C$ 

4) Not subject to production test. Verified by design and characterization.



# Fast Over-Current Detection (OCD)

The Over-Current Detection (OCD) function allows fast detection of over-current events. The raw analog output of the Hall probes is fed directly into comparators with programmable switching thresholds. A user programmable deglitch filter is implemented to enable the suppression of fast switching transients. The two different open-drain OCD pins are active low and can be directly combined into a wired-AND configuration on board level to have a general over-current detection signal. TLE4971 supports two independent programmable OCD outputs, suited for different application needs.

The OCD pins are providing a very fast response, thanks to independence from the main signal path. They can be used as a trap functionality to quickly shut down the current source as well as for precise detection of soft overload conditions.

## **OCD** pins external connection

The OCD pins can be connected to a logic input pin of the microcontroller and/or the gate-driver to quickly react to over-current events. They are designed as open-drain outputs to easily setup a wired-AND configuration and allow monitoring of several current sensors outputs via only one microcontroller pin.

# OCD thresholds

The symmetric threshold level of the OCD outputs is adjustable and triggers an over-current event in case of a positive or negative over-current. The possible threshold levels are listed in Table 7 and Table 8. The instruction for the settings is documented in the TLI4971 programming guide and the TLE4971 addendum.

## OCD outputs timing behavior

Both output pins feature a deglitch filter to avoid false triggers by noise spikes on the current rail. Deglitch filter settings can be programmed according to application needs. Available options are listed in Table 7 and Table 8.

Figure 3 shows the OCD output pin typical behavior during an over-current event.

Over-current Pulse 1: duration exceeds the overcurrent response time  $t_{D_OCDx}$  + response time jitter  $\Delta t_{D_OCDx}$  + deglitch filter time  $t_{deglitch}$ . The OCD output voltage is set low until the current value drops below the OCD threshold.

 $\label{eq:constraint} \begin{array}{l} \text{Over-current Pulse 2: duration does not exceed} \\ \text{the over-current response time } t_{\text{D}\_\text{OCDx}} \text{ and} \\ \text{therefore no OCD event is generated.} \end{array}$ 

Over-current Pulse 3: duration exceeds the response time  $t_{D_OCDx}$  + response time jitter  $\Delta t_{D_OCDx}$ , but does not exceed the glitch filter time  $t_{deglitch}$  and no OCD event is generated.

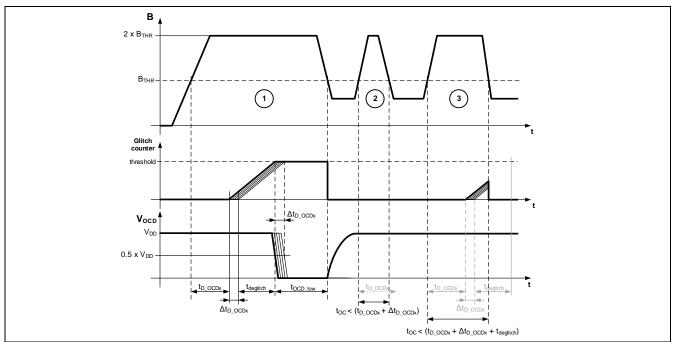


Figure 3 Fast over-current detection output timing

## Fast Over-Current Detection (OCD) Output Parameters

#### Table 6 Common OCD Parameters

General conditions (unless otherwise specified):  $V_{DD}$  = 3.3V;  $T_S$  = -40°C ... +125°C,  $C_L$ =1nF.

Parameter	Symbol	Min	Тур	Max	Unit	Note / Test Conditions
Threshold level tolerance <sup>1)</sup>	I <sub>тнт</sub>	-10	-	10	%	Type tested
Response time jitter <sup>1)</sup>	$\Delta t_{D_OCD}$	-	-	0.25	μs	At 3σ, I <sub>rail</sub> =2xI <sub>THRx.x</sub> , input rise time 0.1μs
Deglitch filter basic time	$t_{ m OCDgl}$	400	500	600	ns	
Detection minimum time	$t_{\text{OCD\_low}}$	3	-	-	μs	Valid for both OCDs
Load capacitance	$t_{OCD\_low}$	-	-	1	nF	
Open-drain current	CL	-	-	1	mA	DC current
Pull-up resistor	R <sub>PU</sub>	1	4.7	10	kΩ	To V <sub>DD</sub>

1) Not subject to production test. Verified by design and characterization.

#### Table 7 OCD1 Parameters

Parameter	Symbol	Min	Тур	Max	Unit	Note / Test Conditions
Threshold level - Level1 <sup>1)2) 3)</sup>	I <sub>thr1.1</sub>	-	1.25	-	x I <sub>FS</sub>	Factor with respect to I <sub>FS</sub> (I <sub>FS</sub> = current full scale according to programming i.e. 120A)
Threshold level - Level2 <sup>1)2)</sup>	<i>I</i> <sub>THR1.2</sub>	-	1.39	-	x I <sub>FS</sub>	Factor with respect to I <sub>FS</sub>
Threshold level - Level3 <sup>1)2)</sup>	I <sub>thr1.3</sub>	-	1.54	-	x I <sub>FS</sub>	Factor with respect to $I_{FS}$
Threshold level - Level4 <sup>1)2)</sup>	<i>I</i> <sub>THR1.4</sub>	-	1.68	-	x I <sub>FS</sub>	Factor with respect to $I_{FS}$
Threshold level - Level5 <sup>1)2)</sup>	<i>I</i> <sub>THR1.5</sub>	-	1.82	-	x I <sub>FS</sub>	Factor with respect to I <sub>FS</sub>
Threshold level - Level6 <sup>1)2)</sup>	<i>I</i> <sub>THR1.6</sub>	-	1.96	-	x I <sub>FS</sub>	Factor with respect to $I_{FS}$
Threshold level - Level7 <sup>1)2)</sup>	<i>I</i> <sub>THR1.7</sub>	-	2.11	-	x I <sub>FS</sub>	Factor with respect to I <sub>FS</sub>
Threshold level - Level8 <sup>1)2)</sup>	<i>I</i> <sub>THR1.8</sub>	-	2.25	-	x I <sub>FS</sub>	Factor with respect to I <sub>FS</sub>
Response time <sup>4)</sup>	$t_{\text{D_OCD1}}$	-	0.7	1	μs	$I_{PN} = 2^* I_{THR1.x}$
Fall time <sup>5)</sup>	t <sub>f_OCD1</sub>	-	100	150	ns	
Deglitch filter setting <sup>2)6)</sup>	OCD1 <sub>gl_mul</sub>	0	-	7	-	$t_{deglitch} = OCD1_{gl_mul} * t_{OCDgl}$ pre-configured setting = 0

1) Symmetric threshold level for positive and negative currents.

2) Can be programmed by user.

3) Pre-configured threshold level

4) Time between primary current exceeding current threshold and falling edge of OCD1-pin at 50%.

5) Not subject to production test. Verified by design and characterization.

6) The specified deglitching timing is valid when input current step overtakes the threshold of at least 10%.

#### Table 8 OCD2 Parameters

Parameter	Symbol	Min	Тур	Max	Unit	Note / Test Conditions
Threshold level - level1 <sup>1)2)</sup>	I <sub>thr2.1</sub>	-	0.5	-	x I <sub>fsr</sub>	Factor with respect to I <sub>FS</sub> (I <sub>FS</sub> = current full scale according to programming i.e. 120A)
Threshold level - level2 <sup>1)2)</sup>	I <sub>THR2.2</sub>	-	0.61	-	x I <sub>FSR</sub>	Factor with respect to $I_{FS}$
Threshold level - level3 <sup>1)2)</sup>	I <sub>THR2.3</sub>	-	0.71	-	x I <sub>FSR</sub>	Factor with respect to I <sub>FS</sub>
Threshold level - level4 <sup>1)2)3)</sup>	I <sub>THR2.4</sub>	-	0.82	-	x I <sub>FSR</sub>	Factor with respect to $I_{FS}$
Threshold level - level5 <sup>1)2)</sup>	<i>I</i> <sub>THR2.5</sub>	-	0.93	-	x I <sub>FSR</sub>	Factor with respect to I <sub>FS</sub>
Threshold level - level6 <sup>1)2)</sup>	<i>I</i> <sub>THR2.6</sub>	-	1.04	-	x I <sub>FSR</sub>	Factor with respect to I <sub>FS</sub>
Threshold level - level7 <sup>1)2)</sup>	<i>I</i> <sub>THR2.7</sub>	-	1.14	-	x I <sub>FSR</sub>	Factor with respect to $I_{FS}$
Threshold level - level8 <sup>1)2)</sup>	I <sub>THR2.8</sub>	-	1.25	-	x I <sub>FSR</sub>	Factor with respect to I <sub>FS</sub>
Response time <sup>4)</sup>	$t_{D_OCD2}$	-	0.7	1.2	μs	$I_{PN} = 2 \times I_{THR2.x}$
Fall time <sup>5)</sup>	t <sub>f_OCD2</sub>	-	200	300	ns	
Deglitch filter setting <sup>2)6)</sup>	OCD2 <sub>gl_mul</sub>	0	-	15	-	$t_{deglitch} = OCD2_{gl_mul} \times t_{OCDgl}$ pre-configured setting = 0

1) Symmetric threshold level for positive and negative currents.

2) Can be programmed by user.

3) Pre-configured threshold level.

4) Time between primary current exceeding current threshold and falling edge of OCD2-pin at 50%.

5) Not subject to production test. Verified by design and characterization.

6) The specified deglitching timing is valid when input current step overtakes the threshold of at least 10%.

# **Undervoltage / Overvoltage detection**

TLE4971 is able to detect undervoltage or overvoltage condition of its own power supply ( $V_{DD}$ ). When an undervoltage ( $V_{DD}$ < $U_{VLOH}$ ) or overvoltage ( $V_{DD}$ > $O_{VLOH}$ ) condition is detected both OCD pins are pulled down in order to signal such a condition to the user.

The undervoltage detection on OCD pins is performed only if  $V_{DD} > V_{DD,OCD}$ .

Both OCD pins are pulled down at start up. When  $V_{DD}$  exceeds the undervoltage threshold  $U_{VLOH_R}$  and the power on delay time  $t_{POR}$  has been reached, the sensor indicates the correct functionality and high accuracy by releasing the OCD pins.

**Table 9 Operating Parameters** 

General conditions (unless otherwise specified): V<sub>DD</sub> = 3.3V; T<sub>S</sub> = -40°C ... +125°C

Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Supply undervoltage lockout threshold	$U_{\rm VLOH_R}$	-	-	2.9	v	$V_{DD}$ at rising edge
Supply undervoltage lockout threshold	U <sub>VLOH_F</sub>	2.5	-	-	v	$V_{DD}$ at falling edge
Supply overvoltage lockout threshold	<b>O</b> vloh	3.55	-	-	v	$V_{DD}$ at rising edge
OCD undervoltage detection limit	V <sub>DD,OCD</sub>	1.8	-	-	v	For V <sub>DD</sub> <v<sub>DD,OCD undervoltage may not be performed.</v<sub>
Undervoltage/overvoltage lockout delay	t <sub>UVLOe</sub>	1	2.4	3.1	μs	Enabled to disabled

1) Not subject to production test. Verified by design and characterization.



# **Isolation Characteristics**

TLE4971 conforms functional isolation.

#### Table 10 Isolation Characteristics

Parameter	Symbol	Min	Тур	Max	Unit	Note / Test Conditions
Maximum rated working voltage (sine wave) <sup>1)2)3)</sup>	V <sub>IOWM</sub>	-	-	690	V	RMS, @ 4000m altitude
Maximum rated working voltage (sine wave) <sup>1)2)3)</sup>	VIOWMP	-	-	975	V	Peak, @ 4000m altitude
Maximum repetitive isolation voltage <sup>2)3)</sup>	V <sub>IORM</sub>	-	-	1150	V	Max DC voltage, spike, @ 4000m altitude
Apparent charge voltage capability (method B) <sup>2)3)</sup>	V <sub>PDtest</sub>	1500	-	-	V	Partial discharge < 5pC peak @ 0m altitude
Isolation test voltage <sup>3)4)</sup>	V <sub>ISO</sub>	3500	-	-	V	RMS, 60s
Isolation production test voltage <sup>4)</sup>	VISOP	3000	-	-	V	RMS, in production, 1.2s, UL certified version
Isolation pulse test voltage <sup>3)</sup>	$V_{pulse}$	6500	-	-	V	Peak, rise time = 1.2µs, fall time = 50µs
Minimum external creepage distance	CPG	4	-	-	mm	
Minimum external clearance distance	CLR	4	-	-	mm	
Minimum comparative tracking index	СТІ	Material group II	-	-	-	
Isolation resistance <sup>3)</sup>	R <sub>IO</sub>	10	-	-	GΩ	U <sub>10</sub> = 500V DC, 1min

1) The given value is considered an example based on pollution degree 2.

2) After stress test according to qualification plan.

3) Not subject to production test. Verified by design and characterization.

4) Agency type tested for 60 seconds by UL according to UL 1577 standard.

TLE4971 characteristics are tested at VDE according basic isolation as well and a report is available on request.



# System integration

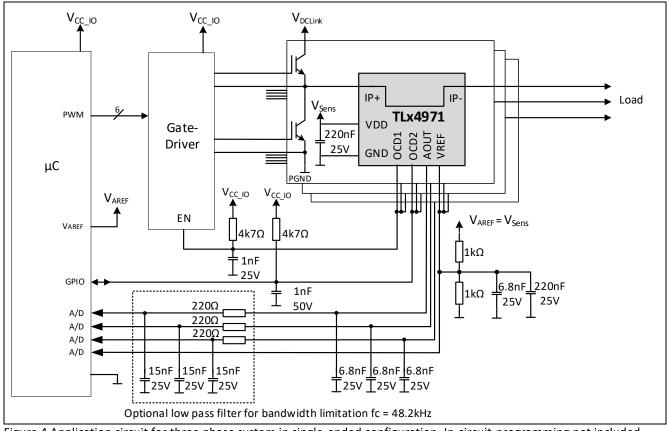


Figure 4 Application circuit for three phase system in single-ended configuration. In-circuit-programming not included.

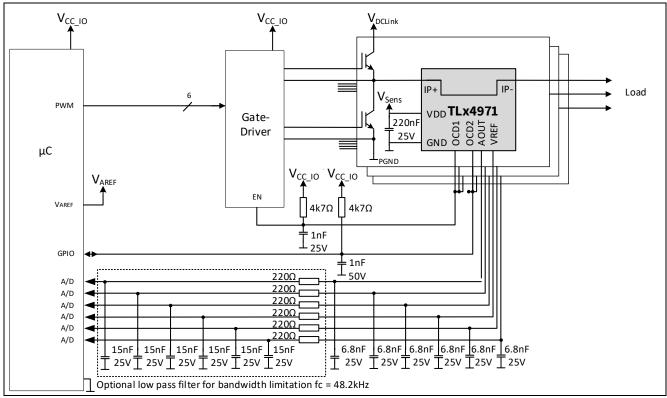


Figure 5 Application circuit for three phase system in differential configuration. In-circuit-programming not included.



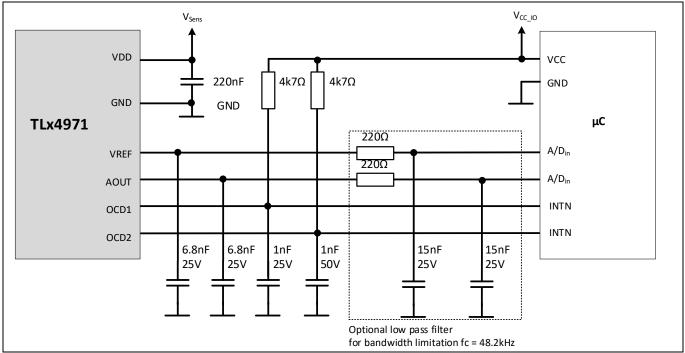


Figure 6 Application circuit with external components. In-circuit-programming not included.

For bandwidth limitation an external filter is recommended as shown in the above application circuits.



# **Typical Performance Characteristics**



Figure 7 Offset error over T (+/-25A version) with 3 sigma limits in green and 1% limit in dotted blue

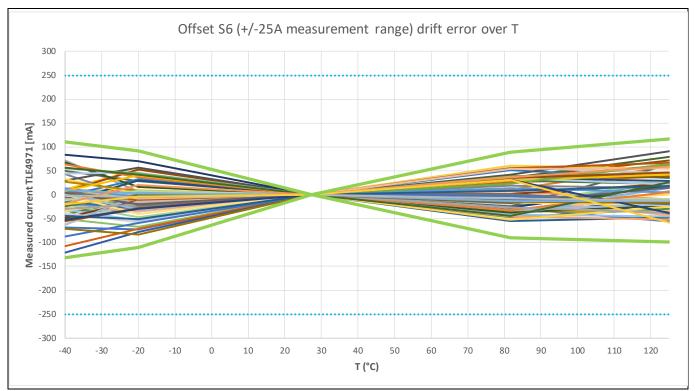


Figure 8 After single point calibration: Offset error over T (+/-25A version) with 3 sigma limits in green and 1% limit in dotted blue



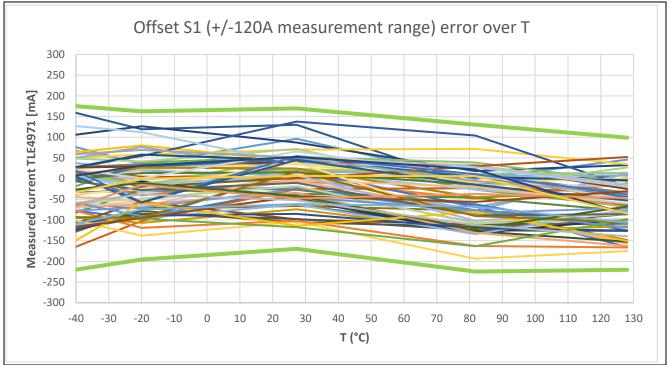


Figure 9 Offset error over T (+/-120A version) with 3 sigma limits in green

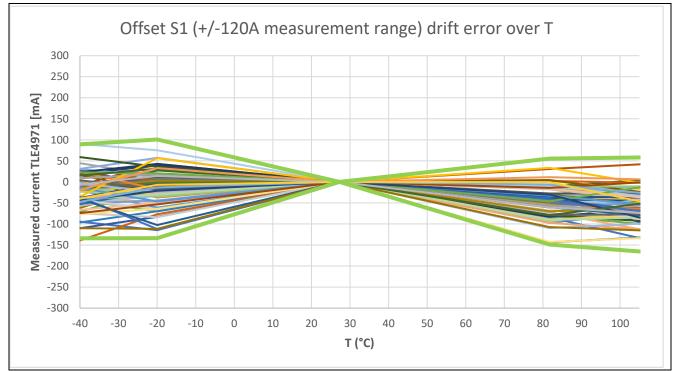


Figure 10 After single point calibration: Offset error over T (+/-120A version) with 3 sigma limits in green



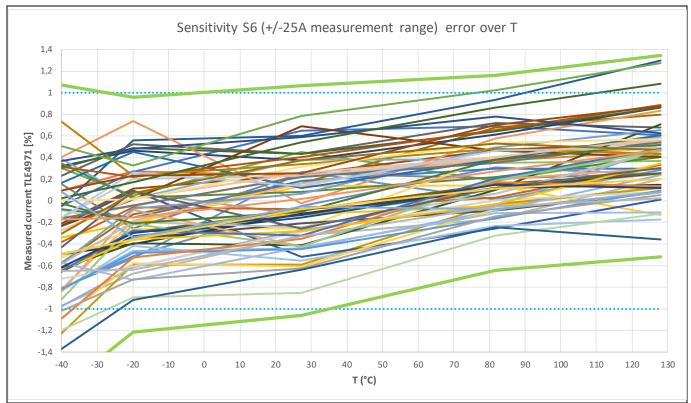


Figure 11 Sensitivity error over T (+/-25A version) with 3 sigma limits in green and 1% limit in dotted blue

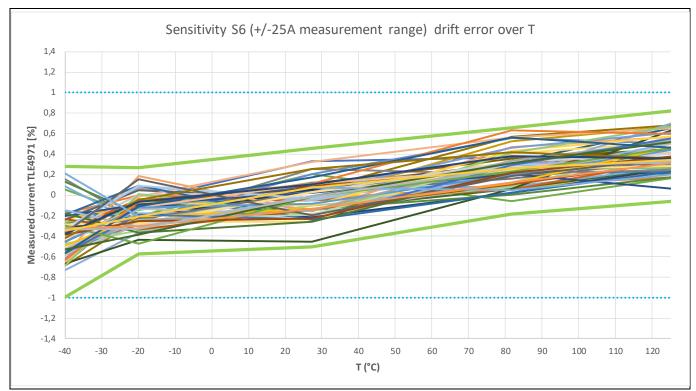


Figure 12 After single point calibration: Sensitivity error over T (+/-25A version) with 3 sigma limits in green and 1% limit in dotted blue



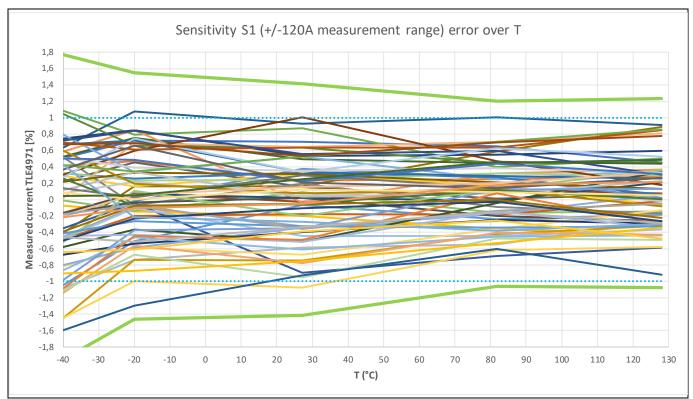


Figure 13 Sensitivity error over T (+/-120A version) with 3 sigma limits in green and 1% limit in dotted blue

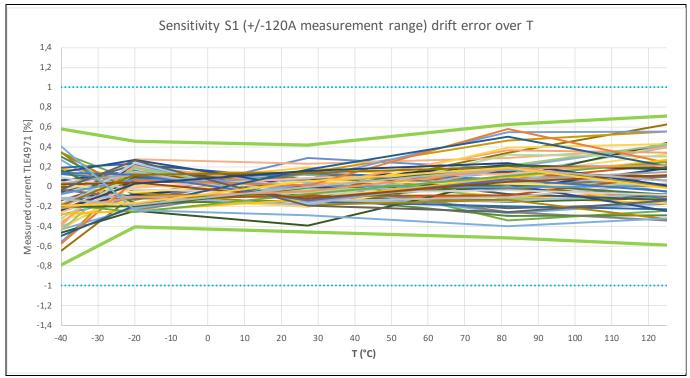
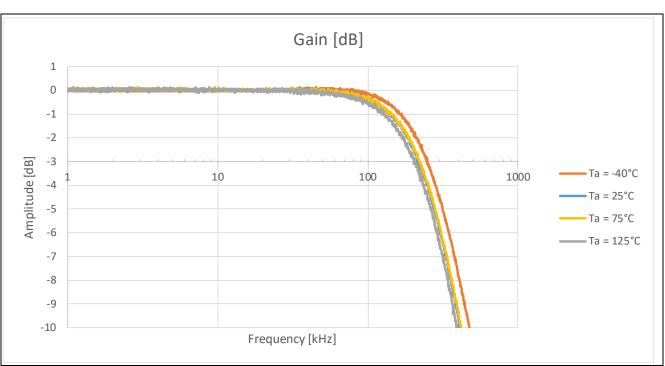


Figure 14 After single point calibration: Sensitivity error over T (+/-120A version) with 3 sigma limits in green and 1% limit in dotted blue



TLE4971 Datasheet

Figure 15 Typical amplitude over frequency

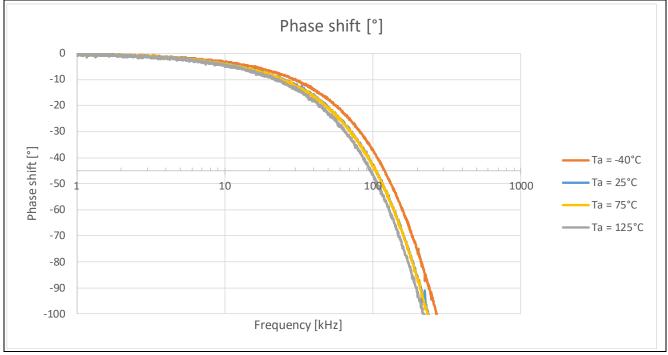


Figure 16 Typical phase-shift over frequency

Infineon

TLE4971
Datasheet



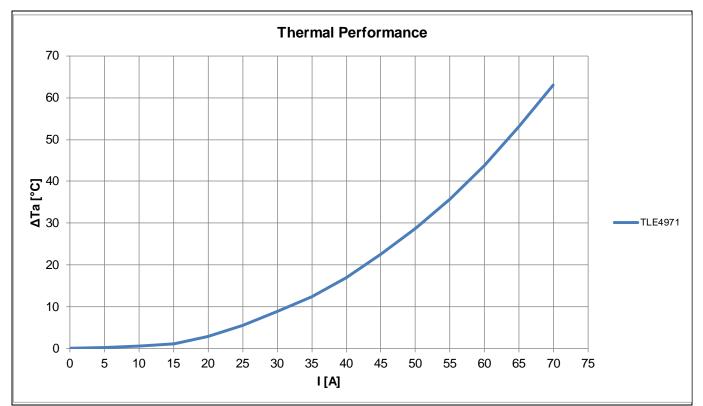
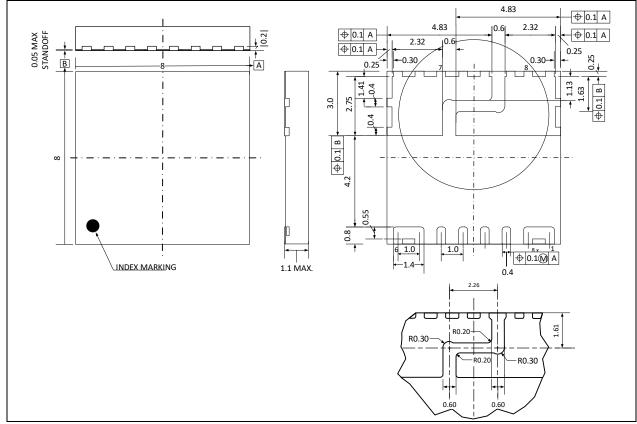


Figure 17 Typical steady state temperature increase



# Package



The TLE4971 is packaged in a RoHS compliant, halogen-free leadless package (QFN-like).

Figure 18 PG-TISON-8-5 package dimensions



# **Revision History**

#### Major changes since the last revision

Date	Description of change			
19-08-2022	V1.02			
	Typo in Table 3 in column "Symbol"			
04-07-2022	V1.01			
	Typo in all eight order numbers on first page (wrong sequence)			
	Editorial changes			
27-05-2022	Initial version			